Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10580052	AKASHI ET AI

1794

Examiner Art Unit Dawn L Garrett

SEARCHED					
Class	Subclass	Date	Examiner		
428	690, 917 (see EAST history for all listed class/subclasses)	9-23-2008	DG		
313	504, 506	9-23-2008	DG		
257	40, E51.051	9-23-2008	DG		
564	434	9-23-2008	DG		

SEARCH NOTES			
Search Notes	Date	Examiner	
STIC structure search by EIC 1700 (M. Huang) (see attached printouts)	9-23-2008 and 9-24-2008	DG	
STN search of registry numbers (see attached)	9-23-2008	DG	
EAST search (see printout); Databases: EPO, JPO, DERWENT, USPAT, USPGPUB	9-23-2008 and 9-24-2008	DG	
Inventor Name Search	9-23-2008	DG	
reviewed prior STIC search printouts in application file	5-15-2009	DG	
updated Inventor Name Search	5-15-2009	DG	
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5-15-2009	DG	

	INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner	
	Interference search done in EAST in USPAT and USPGPUB databases, keywords searched in claim field (see Interference Search history printout)	5-15-2009	DG	

U.S. Patent and Trademark Office Part of Paper No.: 20090515